

	Type	L #	Hits	Search Text	DBs	Time Stamp
1	IS&R	L1	99	(("6426072") or ("6436703") or ("6287765") or ("5377197") or ("6446243") or ("4534028") or ("6274564") or ("6369046") or ("6475753") or ("4924429") or ("5910901") or ("6523151") or ("6309879") or ("5754760") or ("6410709") or ("4901259") or ("5412665") or ("5958077") or ("6370475") or ("6405132") or ("5983381") or ("5657240") or ("5708594") or ("6145106") or ("6011830") or ("6310034") or ("5910958") or ("5517637") or ("6395889") or ("4763289") or ("5341315") or ("5371851") or ("6347388") or ("5465216") or ("6065144") or ("6295623") or ("5525477") or ("6342581") or ("6420526") or ("5539680") or ("5257268") or ("5027355") or ("6337344") or ("6355636") or ("6440340") or ("6070261") or ("6560568") or ("5239262") or	USPAT	2004/04/26 09:40
2	BRS	L2	15	1 and simulate and circuit and test and events	USPAT	2004/04/26 11:11
3	IS&R	L3	1	("5729554").PN.	USPAT	2004/04/26 10:21
4	BRS	L4	1	3 and simulate and circuit and test and event and taken	USPAT	2004/04/26 10:21
5	BRS	L5	5	1 and simulate and circuit and test and occurrence	USPAT	2004/04/26 11:12
6	BRS	L6	1	5 not 2	USPAT	2004/04/26 11:15
7	BRS	L7	0	(input with test with cases) same (output with frequency with events)	USPAT; EPO; JPO; DERWEN T	2004/04/26 11:16

	Type	L #	Hits	Search Text	DBs	Time Stamp
8	BRS	L8	0	(input with test with cases) same (output with occurrence with events)	USPAT; EPO; JPO; DERWEN T	2004/04/26 11:21
9	BRS	L9	5	(input with test with cases) and (output with occurrence with events)	USPAT; EPO; JPO; DERWEN T	2004/04/26 11:35
10	BRS	L10	5	(input with test with cases) and (output with frequency with events)	USPAT; EPO; JPO; DERWEN T	2004/04/26 11:35
11	BRS	L11	5	10 not 9	USPAT; EPO; JPO; DERWEN T	2004/04/26 11:36
12	BRS	L12	557	(test with cases) and (events with occurrences) and circuit	USPAT; EPO; JPO; DERWEN T	2004/04/26 12:03
13	BRS	L13	179	12 and (simulating or simulation)	USPAT; EPO; JPO; DERWEN T	2004/04/26 11:38
14	BRS	L14	45	(test with cases) and (events with occurrences) and (event with non with occurrences)	USPAT; EPO; JPO; DERWEN T	2004/04/26 12:17
15	BRS	L15	318	(test with generation) and (events with occurrences)	USPAT; EPO; JPO; DERWEN T	2004/04/26 12:17

	Type	L #	Hits	Search Text	DBs	Time Stamp
16	BRS	L16	249	15 and circuit	USPAT; EPO; JPO; DERWEN T	2004/04/26 12:18
17	BRS	L17	115	16 and (simulate or simulation)	USPAT; EPO; JPO; DERWEN T	2004/04/26 12:18
18	BRS	L18	95	17 and non	USPAT; EPO; JPO; DERWEN T	2004/04/26 12:18